

**Search Notes**

Application/Control No.

10/500,451

Examiner

/Mark L. Berch/

Applicant(s)/Patent under  
Reexamination

HAYASHI ET AL.

Art Unit

1624

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
544/276 plus text term to date	7/18/2006	MLB